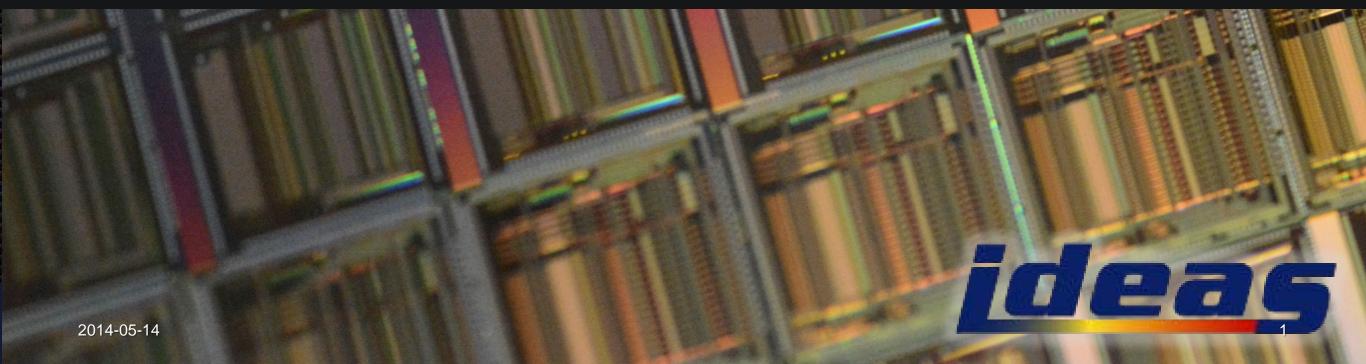


#### ASIC Development for Space Radiation Monitors at IDEAS

#### Integrated Detector Electronics AS

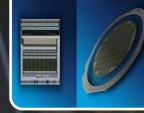
Presented to the European Space Plasma and Radiation Workshop, ESTEC, May 14 2014 Philip Påhlsson, Development Engineer, philip.pahlsson@ideas.no



#### ASIC Development for Space Radiation Monitors at IDEAS



**IDEAS** company overview



**ASIC** Heritage and ASIC families



Selection of ASICs for space radiation and plasma monitoring

#### Integrated Detector Electronics AS

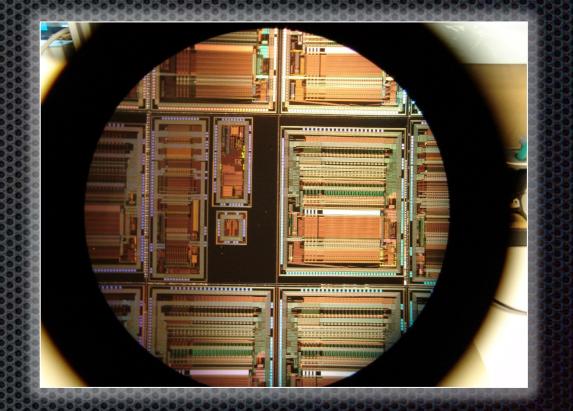
Presented to the European Space Plasma and Radiation Workshop, ESTE Philip Pahlsson, Development Engineer, philip.pahlsson@ideas.no

2014-05-14



## IDEAS overview

IDEAS - Integrated Detector Electronics AS develops and sells integrated circuits for radiation detection and imaging applications. The company was founded in 1992 with strong background in applied physics, radiation detector instrumentation and electrical engineering. The headquarter is located near Oslo, Norway. IDEAS products are used in medical imaging, industrial inspection, nuclear science and astrophysics. The circuits can be delivered in any quantity to commercial and scientific customers worldwide.







## **IDEAS** staff

2 Ph.D. Physicists with Nuclear Science and HEP

1 Ph.D. Electronics Engineer, Digital Systems

6 M.Sc Integrated Circuit Designers

2 M.Sc Electronic Design Engineers

2 M.Sc Space Engineering

1 Electronic Design/Validation Engineer

1 Technician

1 M.Sc. Senior Accountant





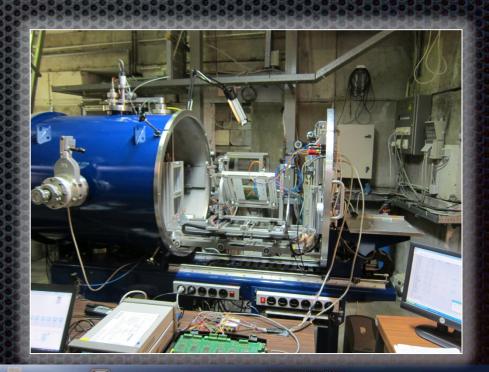




## **IDEAS** validation

Temperature Chamber Cryogenic Dewar X-ray Source Radioactive sources

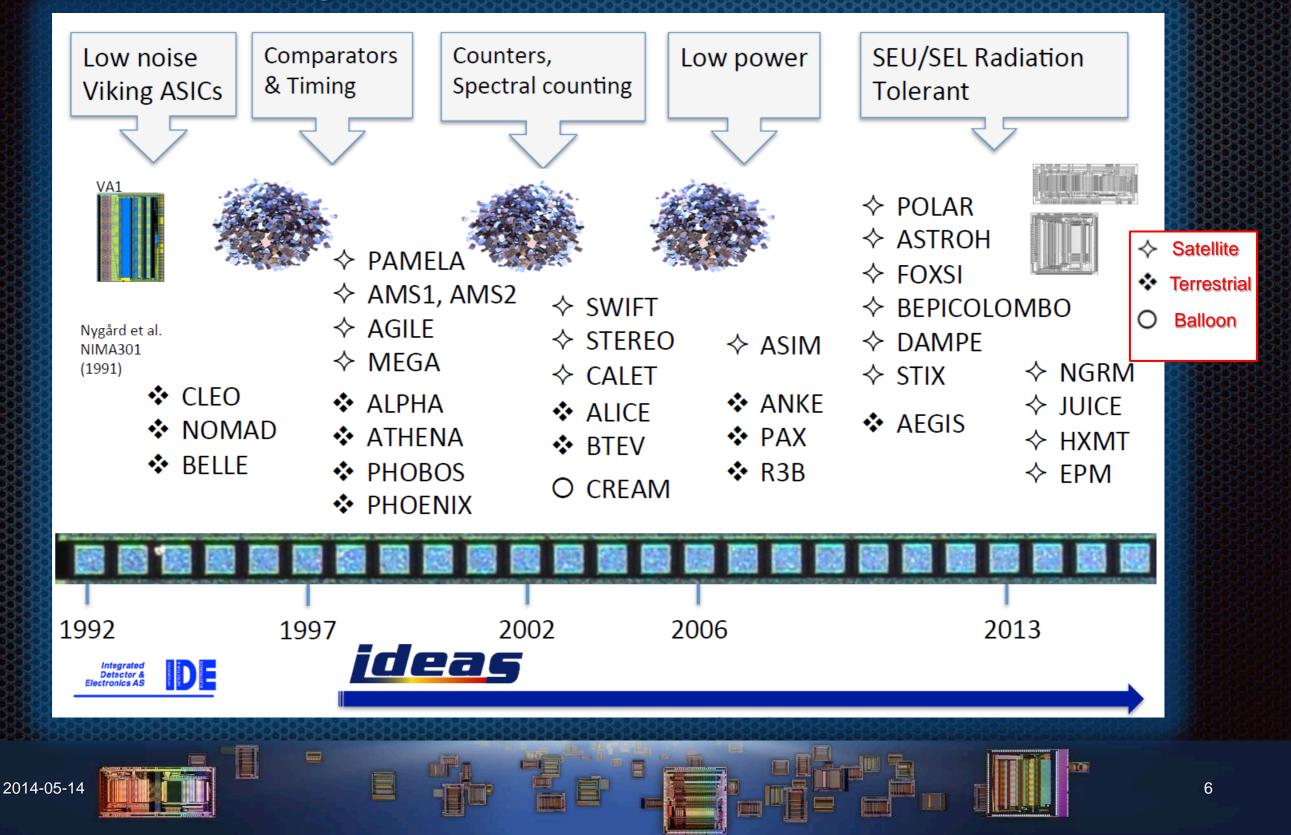
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Validation	Standard
SEE	ESCC-25100
TID	ESCC-22900
SEM	ESCC-21400



#### ASIC heritage for Science



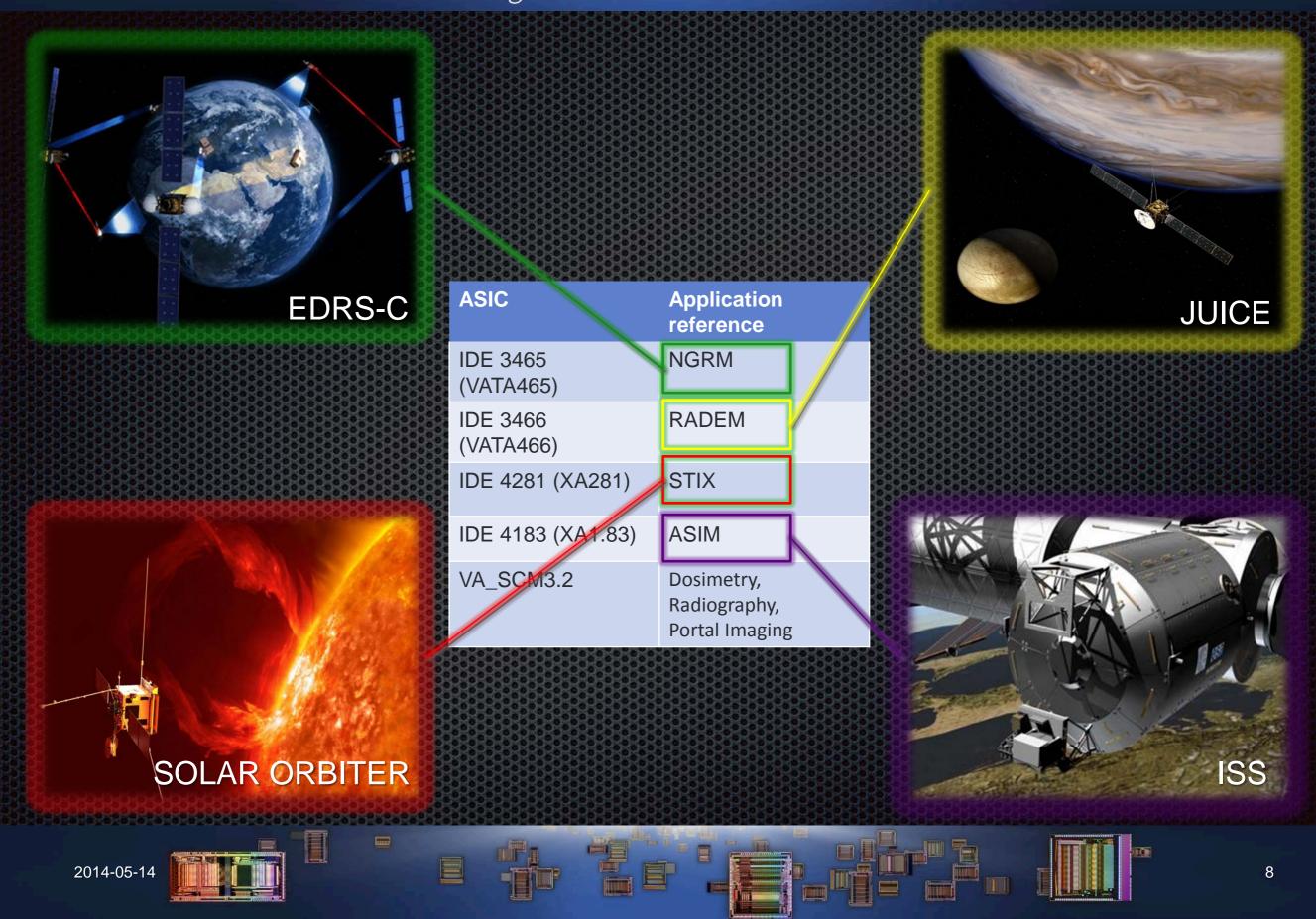


# Selection of ASICs

ASIC	Application reference
IDE 3465 (VATA465)	NGRM
IDE 3466 (VATA466)	RADEM
IDE 4281 (XA281)	STIX
IDE 4183 (XA1.83)	ASIM
VA_SCM3.2	Dosimetry, Radiography, Portal Imaging



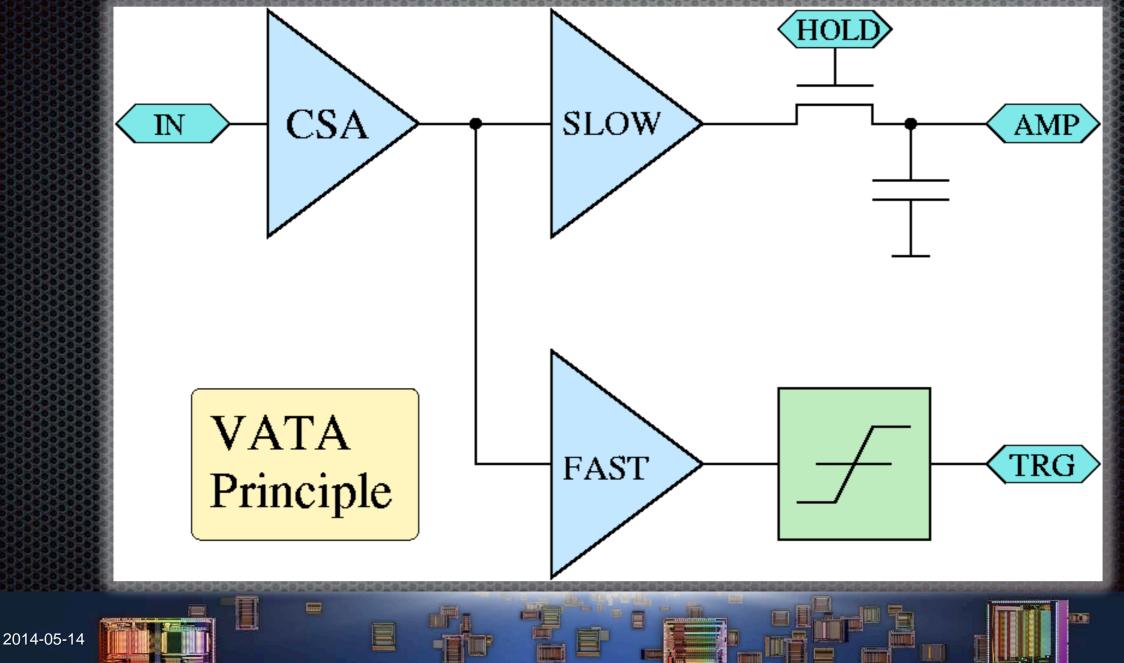
#### **ideas** Integrated Detector Electronics AS





### VATA - family ASICs

ASICs for spectroscopy with on-chip trigger, system driven

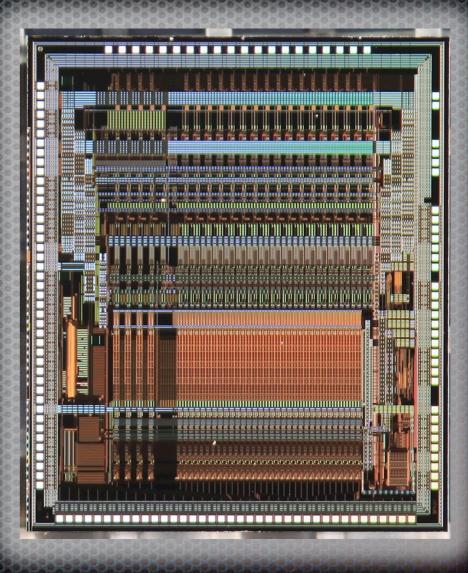




## IDE 3465 – NGRM

The IDE 3465 is an application specific integrated circuit (ASIC) that has been designed for the readout of the p-side of silicon detectors.

		ŏ.
Supplier	IDEAS	00000
Wafer fab	AMS	0000
Technology	0.35 μm CMOS	000000
Epitaxial layer	Yes	0000
Metal Layers	4	
Capacitor option	Double poly	00000
Chip dimensions	6045 μm × 7140 μm	00000







## IDE 3465 – NGRM

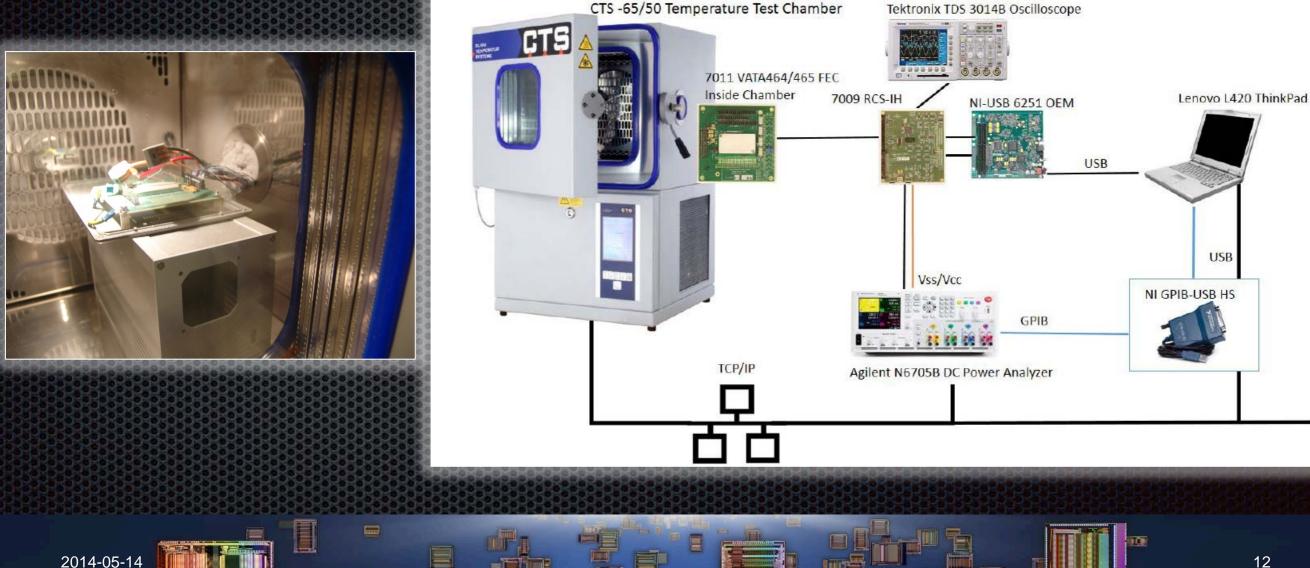
		0000000	265	0000			
20 charge	< 2.6 pC in 16 high-gain channels	000	_		HOLDB		
sensitive inputs	< 26 pC in 4 low-gain channels	In0			16 high-gain channels		
37 digital logic trigger outputs	32 outputs from the 2 comparators in the high-gain channels	In15					
	4 outputs from the comparator in the low-gain channels	0000		ADEMUX			T_OUT0A
	1 OR from all comparators			AD	threshold DAC		 T_OUT15A
1 analogue	Pulse height spectroscopy from all channels	0000					T_OUT0B
output		000			threshold DAC		T_OUT15B
Noise	0.45 fC ENC in high-gain channels	In16			4 low-gain channels		
	5 fC ENC in low-gain channels	 In19					
Trigger	1.5 fC and 71 fC in high-gain channels		•				
threshold,	150 fC in low-gain channels	000		×			
minimum				EMU			T_OUT16
Power	62.5 mW maximum, typical consumption 50 mW			ADI			 T_OUT19
Rate,	> 1 Mcps/channel capability at the trigger outputs	000					
maximum	> 2.5 kcps/channel with analogue readout of all	000		×	SC_CLK REGIN DRESET RO_CLK SHIFT_IN	4	T_OUT
	channels			ADEMUX	D RES D RES TOR	T	1_001
Radiation	The chip is SEL immune (SEL LET <sub>th</sub> >100			AD	Bias Network Configuration		T_OUTB
tolerance	MeV/mg/cm2)			T		-	AOUTP
	The chip is radiation tolerant by design and	000		<b>_</b>			AOUTM
	manufacture, with respect to single event upsets	000		CAL	MBIAS REGOUT READ_BACK LOAD SHIFT_OUT VREF		

2014-05-14



#### Design validation – temperature

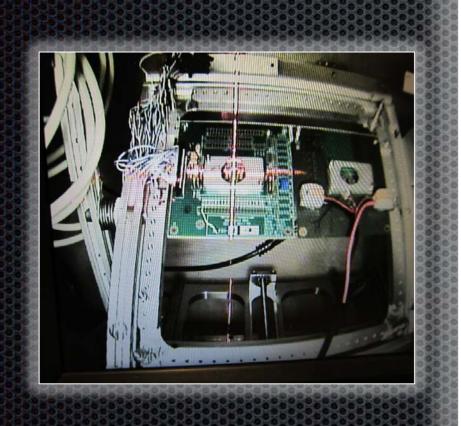
Validated operating temperature -65°C to +40°C at IDEAS

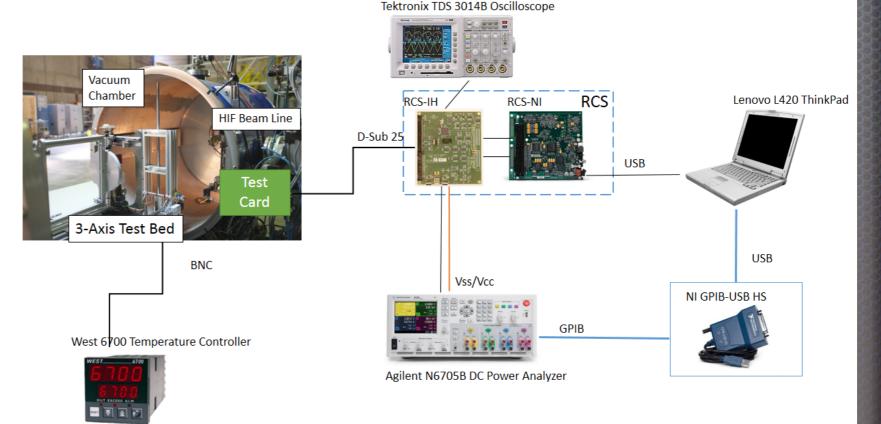




#### **Design validation – radiation**

#### SEE tests performed at UCL SEL<sub>th</sub> >116 MeVcm<sup>2</sup>/mg 80°C ASIC temperature in accordance with ESCC 25100



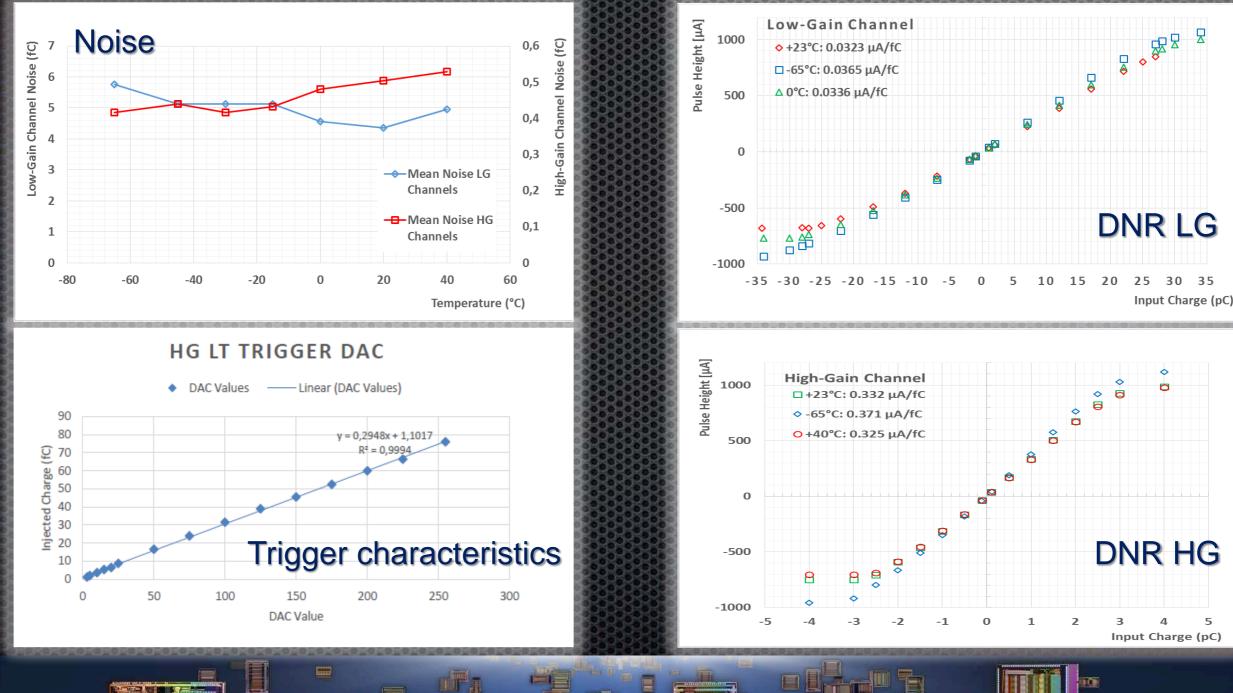






#### **NGRM ASIC** validation

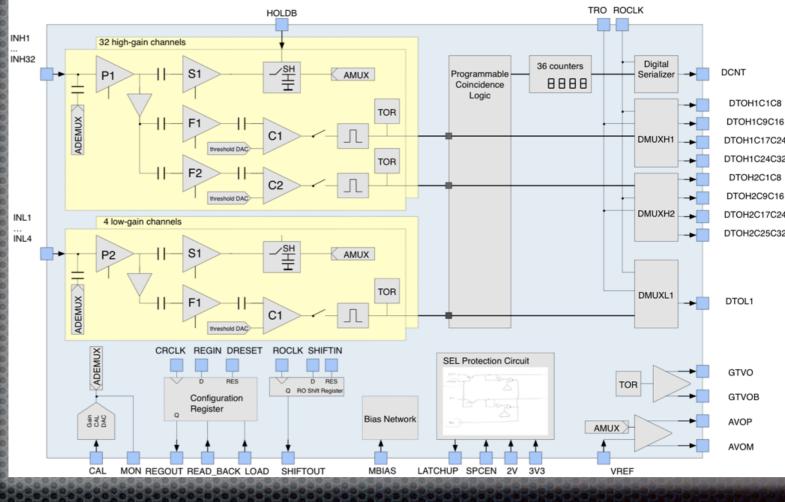
2014-05-14





# IDE 3466 – RADEM

The IDE 3466 is an application specific integrated circuit (ASIC) for RADEM with heritage from IDE 3465.



#### **Features**

On-chip event counting

SEL protection circuit

32 HG channels and 4 LG channels

Dynamic range: 2.6 fC HG 26 fC LG

Radiation hard by design

2014-05-14





### IDE 3466 – RADEM

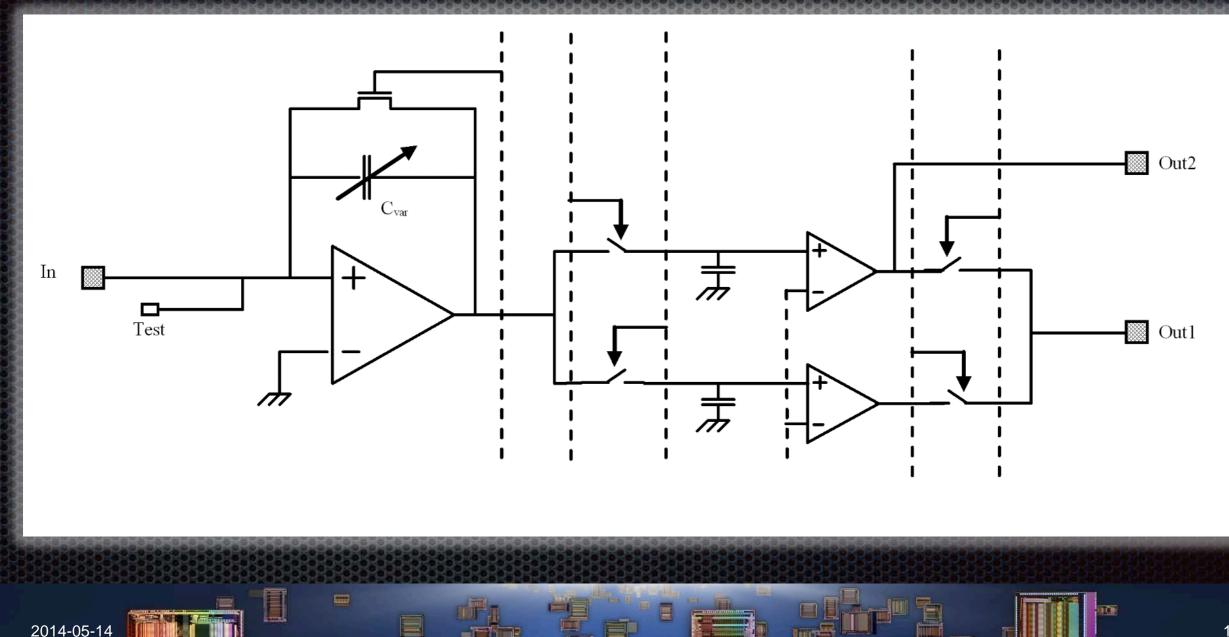
Validation with functional, performance and operational testing SEM testing in accordance with ESCC-21400 Radiation testing in accordance to ESCC-25100 and ESCC-22900





# VAI – family ASICs

ASICs with current integrators





# VA SCM3.2

The VS\_SCM3.2 is a current integrator ASIC designed to read out a variety of detectors

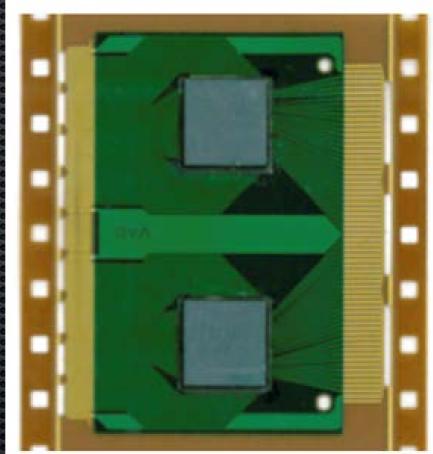
#### **Continuus current integration mode**

Correlated double sampling mode

128 input channels

Multiple pre-amplifier gain settings

Dynamic range ±20 pC



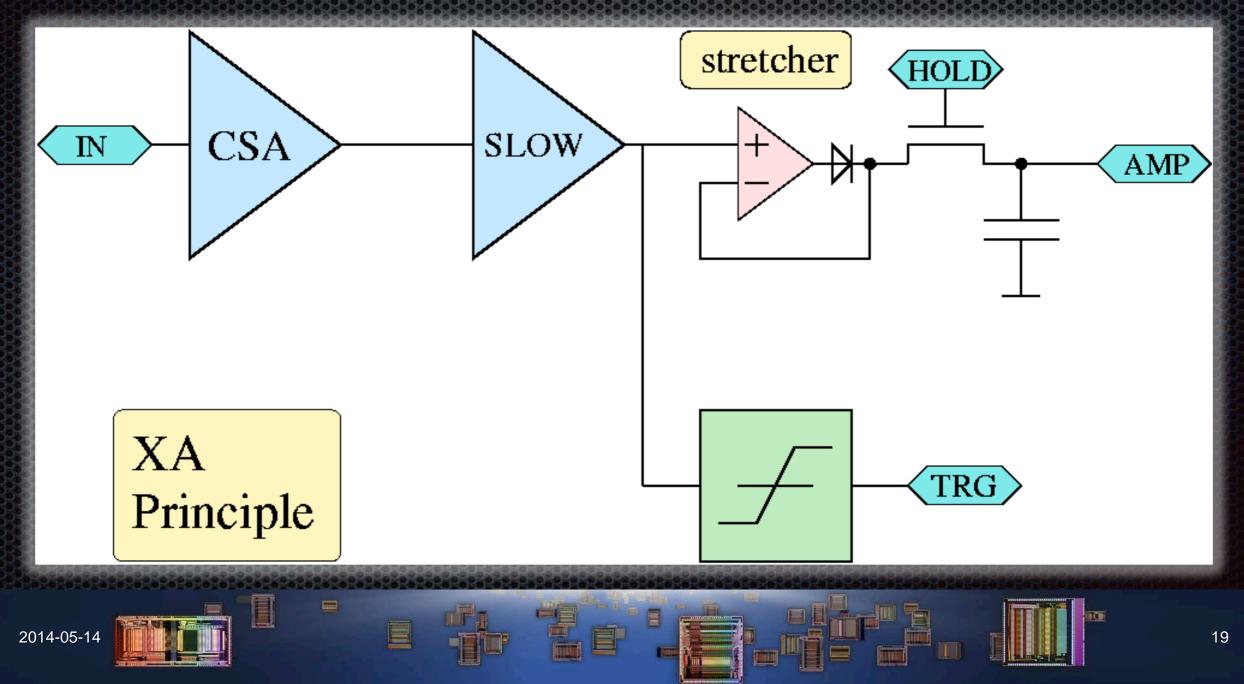






## XA – family ASICs

ASICs for spectroscopy with on-chip trigger, self-triggering





# XA1.83 – ASIM

The XA 1.83 is an application specific integrated circuit (ASIC) that has been designed for the readout of CZT pixelated radiation detectors

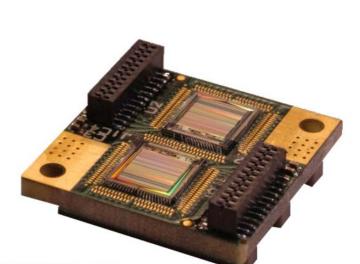
Each CZT pixel measures energy from 20 keV to 360 keV A total of 128 ASICs (16384 channels) of XAs will be used in the Atmosphere Space Interaction Monitor (ASIM).

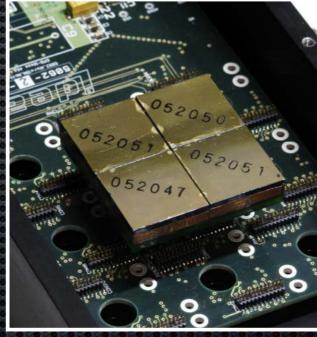
Trigger address encoding

65536 channels can be daisy-chained

Temperature drift compensation

Also used in LumaGEM Molecular Breast Imaging camera



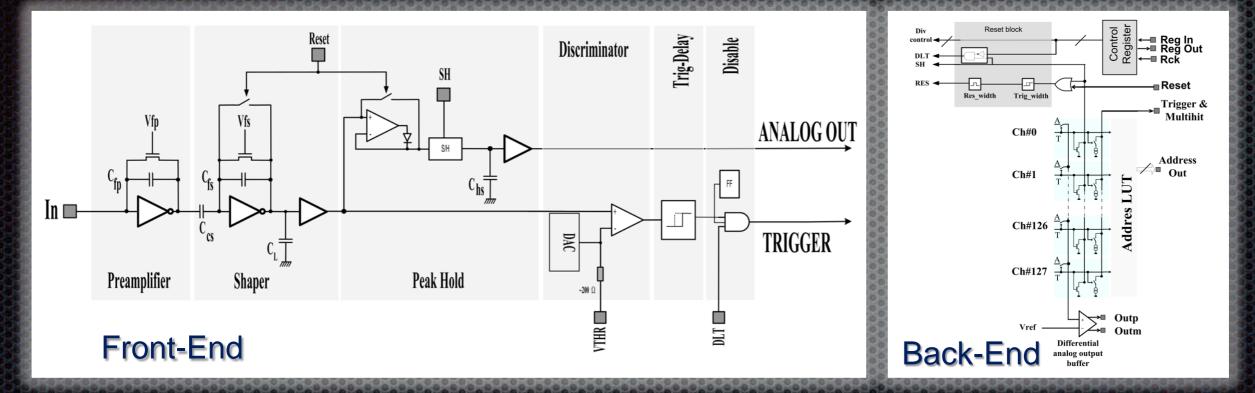








XA1.83



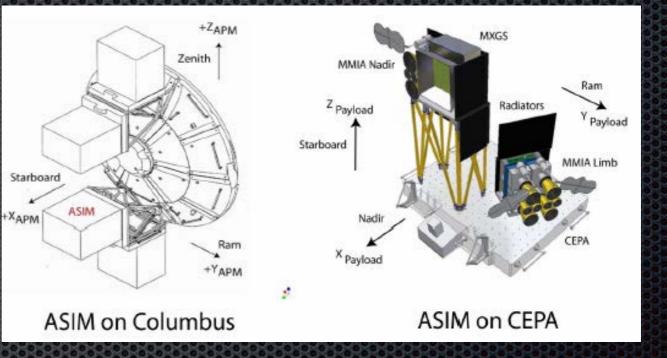


To:



### XA1.83

Parameter	Value	Comment
Number of Input Channels	128	Readout for 128 pixels
Input charge dynamic range	012.5 fC	Negative charge, readout of anodes
Power consumption	0.5 mW/channel	64 mW total (nominal setting)
Electronic noise of CSA	130 e + 20 e/pF	At 0.5-µs shaping time.
		Measured energy resolution is 5.4 keV FWHM at 122 keV in CZT pixels
Threshold	0.3 fC, negative charge	10 keV in CZT
Rate capability, maximum	20 kHz 100 kHz per ASIC	Highest rate tested with this ASIC is 20 kHz. Depending on system configuration, >100 kHz is expected to be possible
Detector Capacitance	0 pF 10 pF	Optimized for 4pF
Detector Leakage Current	0 nA – 100 nA	Positive current out of the preamplifiers

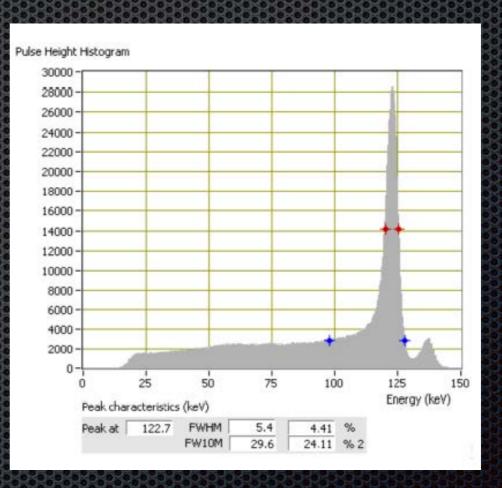






### XA1.83

## 5.4 keV FWHM at Co-57 122 keV, all pixels summed.







## IDE 4281

The IDE 4281 is an application specific integrated circuit (ASIC) that has been designed for the readout of CdTe/CZT radiation detectors in space.

Single photon spectroscopy of x-rays and  $\gamma$ -rays with energy between 3.5 keV and 140 keV @100 kHz per chip

12 channels

Programmable peaking time

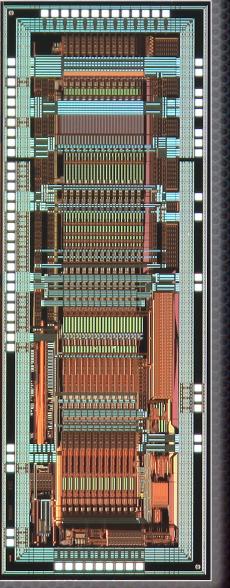
Trigger address encoding

19 mW idle/25 mW maximum

Radiation hard by design

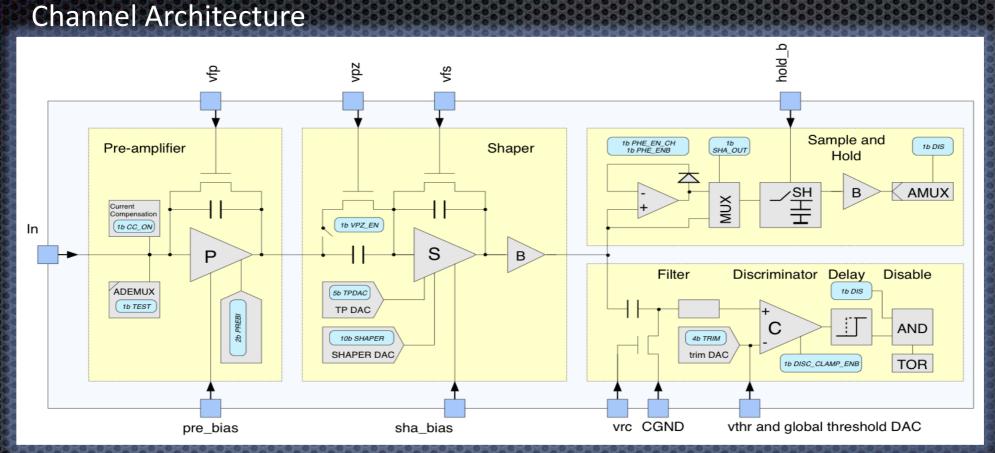
The ASIC was designed for the STIX detector unit. STIX is one of 10 instruments on board Solar Orbiter, a confirmed M-class mission of the European Space Agency to be launched in 2017. STIX has 32 pixelated CdTe detectors for detection of hard x-ray emissions from 4 keV to 150 keV. STIX foresees using the IdeF-X HD chip [Meuris et al., IEEE TNS, April 2008]. The IDE 4281 was an alternative chip solution for STIX.







# IDE 4281



Charge Sensitive Pre-amplifier (P)

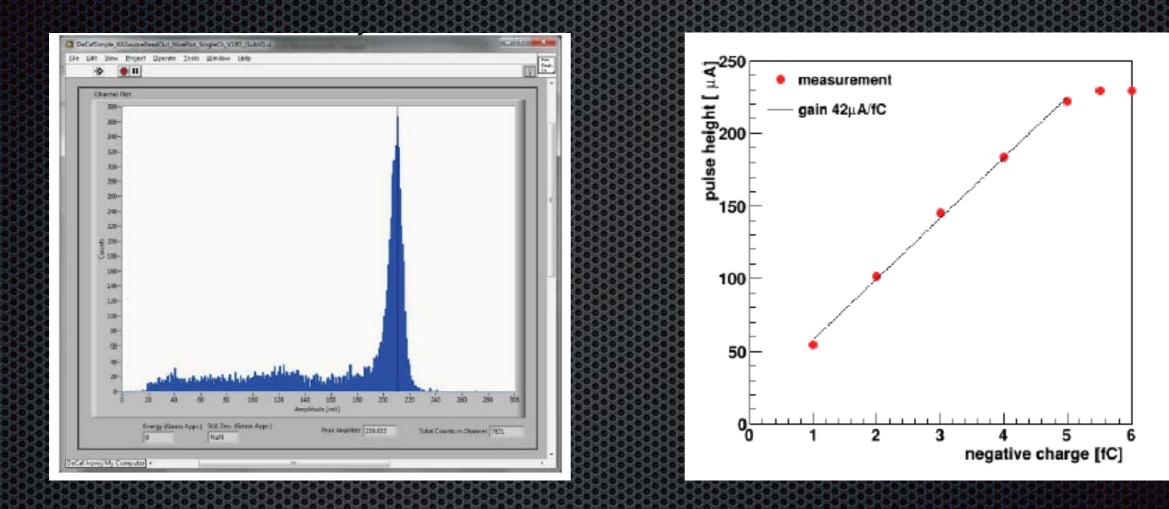
- Programmable Shaper (S), Pole-Zero Cancellation
- Stretcher (peak-hold devices), sample and hold (SH)
- Analogue Multiplexer Readout (AMUX)
- Comparators (C), programmable reference
- Mono-stable Trigger Outputs, Trigger OR (TOR)

#### **Radiation tolerant/hardened library**

- Full custom guard rings against SEL
- Epitaxial layer process against SEL
- Triple redundant flip-flops correct for SEU
- Sub-µm CMOS technology improves TID
- SEL/SEU LET<sub>th</sub> > 67.7 MeVcm2/mg



### IDE 4281



Pulse height spectrum from a channel at +21°C, γ from Am-241, eV-Products CZT.

